

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION (FORM PTO-1449)ATTY. DOCKET NO.
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Rycharde Jeffery HAWKES, et alFILING DATE
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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
JL	5,758,281	05-1998	EMERY et al.			
JL	5,907,547	05-1999	FOLADARE et al.			
JL	5,914,951	06-1999	BENTLEY et al.			
JL	5,954,798	09-1999	SHELTON et al.			
JL	5,956,027	09-1999	KRISHNAMURTHY			
JL	6,006,269	12-1999	PHAAL			
JL	6,035,332	03-2000	INGRASSIA et al.			
JL	6,076,100	06-2000	COTTRILLE et al.			
JL	6,167,432	12-2000	JIANG			
JL	6,181,697	01-2001	NUREMBERG et al.			
JL	6,259,701	07-2001	SHUR et al.			
JL	6,295,550	09-2001	CHOUNG et al.			
JL	6,295,551	09-2001	ROBERTS et al.			
JL	6,349,290	02-2002	HOROWITZ et al.			
JL	6,385,646	05-2002	BROWN et al.			
JL	6,418,471	07-2002	SHELTON et al.			
JL	6,430,567	08-2002	BURRIDGE			
JL	6,434,599	08-2002	PORTER			
JL	6,442,590	08-2002	INALA et al.			
JL	6,487,195	11-2002	CHOUNG et al.			
JL	6,654,457	11-2003	BEDDUS et al.			
JL	6,654,815	11-2003	GOSS et al.			
JL	6,665,395	12-2003	BUSEY et al.			
JL	6,687,241	02-2004	GOSS			
JL	6,687,877	02-2004	SASTRY et al.			
JL	6,690,654	02-2004	ELLIOTT et al.			
JL	6,697,858	02-2004	EZERZER et al.			
JL	6,748,420	06-2004	QUATRANO et al.			
JL	6,771,766	08-2004	SHAFIEE et al.			
JL	6,810,405	10-2004	LaRUE et al.			
JL	6,826,194	11-2004	VERED et al.			



FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>SG</i>	WO 98/37687 A1	08/27/1998	WIPO			Yes	No
<i>SG</i>	WO 98/59461 A2	12/30/1998	WIPO			Yes	No
<i>SG</i>	WO 99/18514 A1	04/15/1999	WIPO			Yes	No
<i>SG</i>	WO 00/03329 A1	1/20/2000	WIPO			Yes	No
<i>SG</i>	WO 01/03036 A1	01/11/2001	WIPO			Yes	No
<i>SG</i>	WO 01/24092 A1	04/05/2001	WIPO			Yes	No
<i>SG</i>	2 359 215 A	8/15/2001	United Kingdom			Yes	No
						Yes	No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	<i>SG</i>			DATE CONSIDERED <i>2/11/05</i>			

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